

Notice of References Cited	Application/Control No. 10/810,385		Applicant(s)/Patent Under Reexamination LU ET AL.	
	Examiner John Ruggles		Art Unit 1756	Page 1 of 1

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NON-PATENT DOCUMENTS

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*	U	Phillippe Lalanne and Mike Hutley, The Optical Properties of Artificial Media Structued at a Subwavelength Scale, (9/9/03), Encyclopedia of Optical Engineering, R. Driggers, Ed., Marcel Dekker, New York (2003), Pages 1-11 [Document CH in the 3/26/04 IDS]
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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